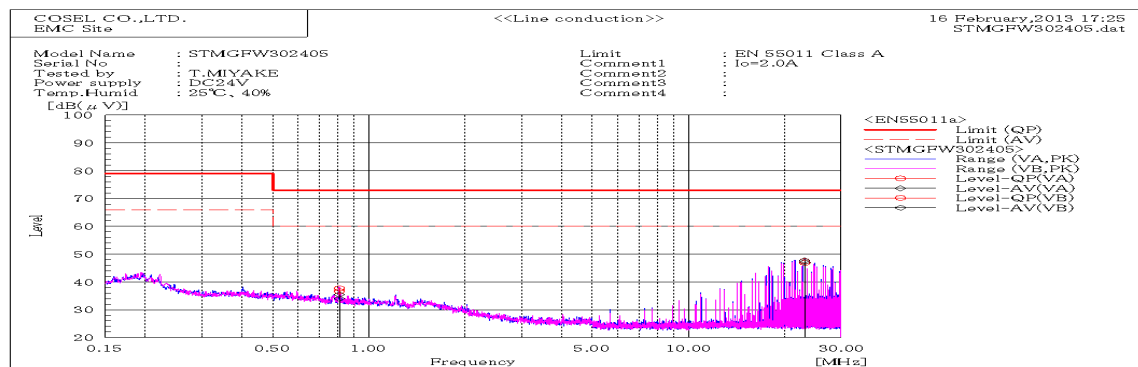
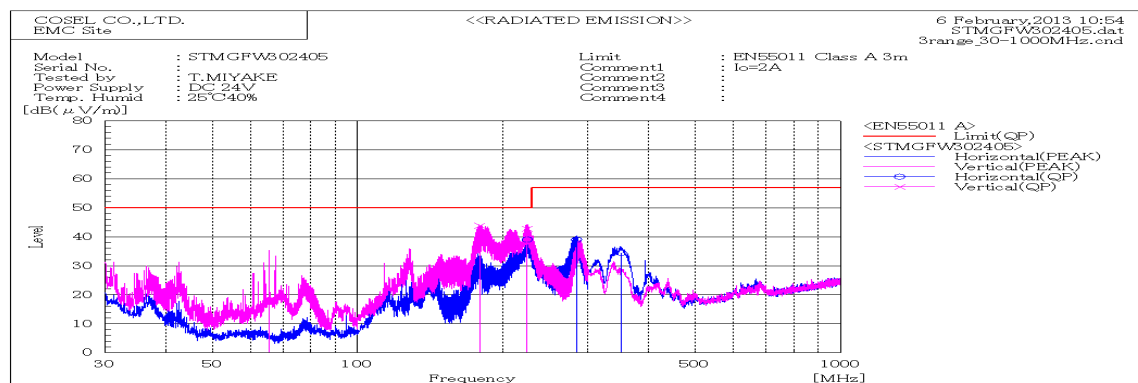


## DATA SHEET

Model	STMGFW302405	Date	18-Feb-13
Test	EMI Line conduction & Radiated emission	Temp.	25 degreeC
		Humid.	40 %RH
		Tested by	T.Miyake



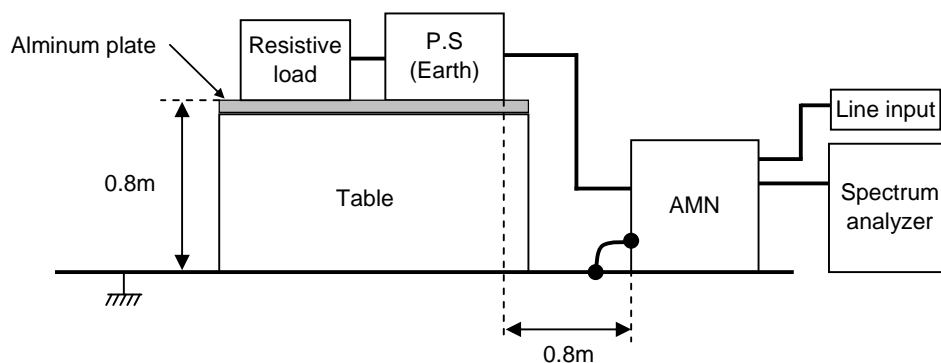
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.80869		VB	17.6	15.3	20.1	37.7	35.4	73	60	35.3	24.6	Pass	
0.80863		VA	16.6	14	20.1	36.7	34.1	73	60	36.3	25.9	Pass	
23.0796		VB	25.8	26	21.1	46.9	47.1	73	60	26.1	12.9	Pass	
23.07605		VA	26.4	26.6	21.1	47.5	47.7	73	60	25.5	12.3	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	AV						
65.759	V	Stable	40.4	-21.9		18.5		50	31.5	Pass	126	245	
179.031	V	Stable	59.8	-16		43.8		50	6.2	Pass	101	265	
224.51	V	Stable	58.2	-15.4		42.8		50	7.2	Pass	103	305	
224.519	H	Stable	59.4	-20.4		39		50	11	Pass	122	246	
284.16	H	Stable	56.9	-17.9		39		57	18	Pass	116	68	
351.594	H	Stable	47.6	-13.2		34.4		57	22.6	Pass	113	68	

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

## 1. Line conduction



## 2. Radiated emission

